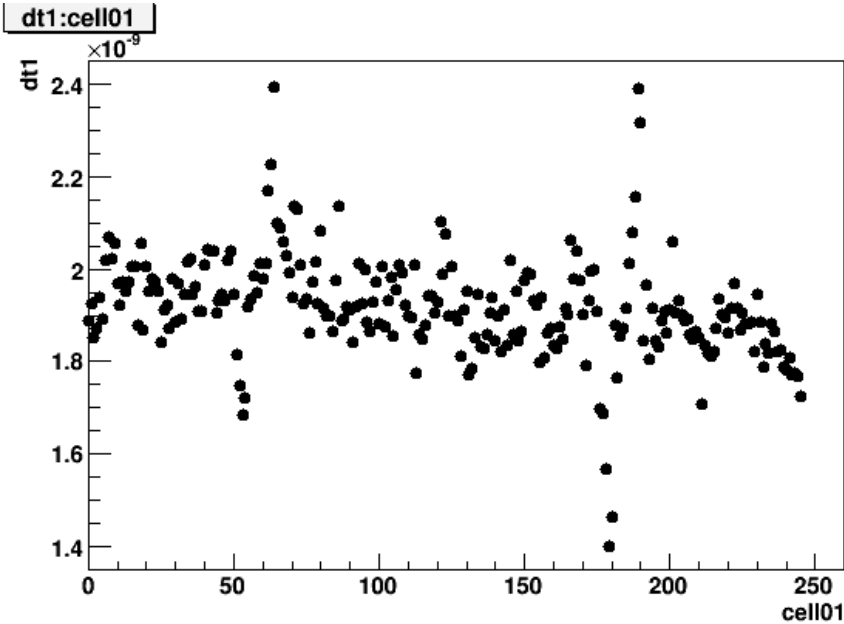


Timing Calibration Updates

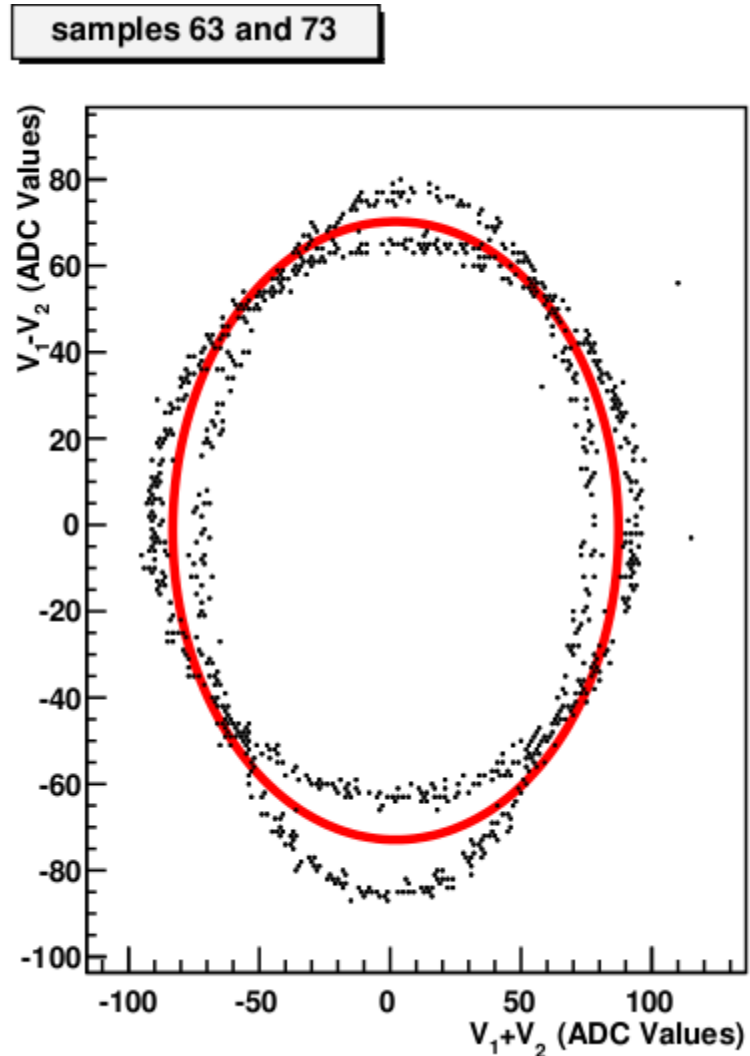
Kurtis Nishimura

April 6, 2011

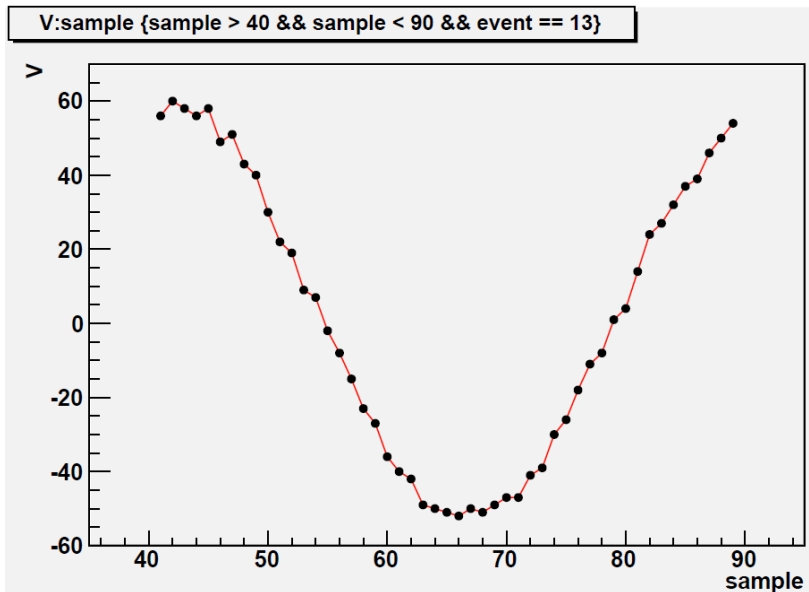
Last PSEC3 Data Anomalies



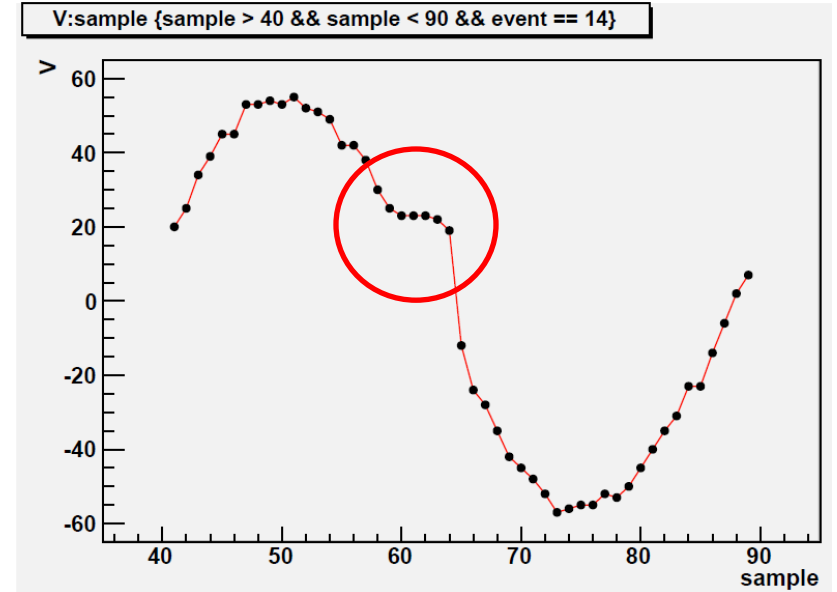
Last time, found some strange behavior in fits at cells 50-60, 170-190.



Last PSEC3 Data Anomalies



Normal waveform



Anomalous waveform

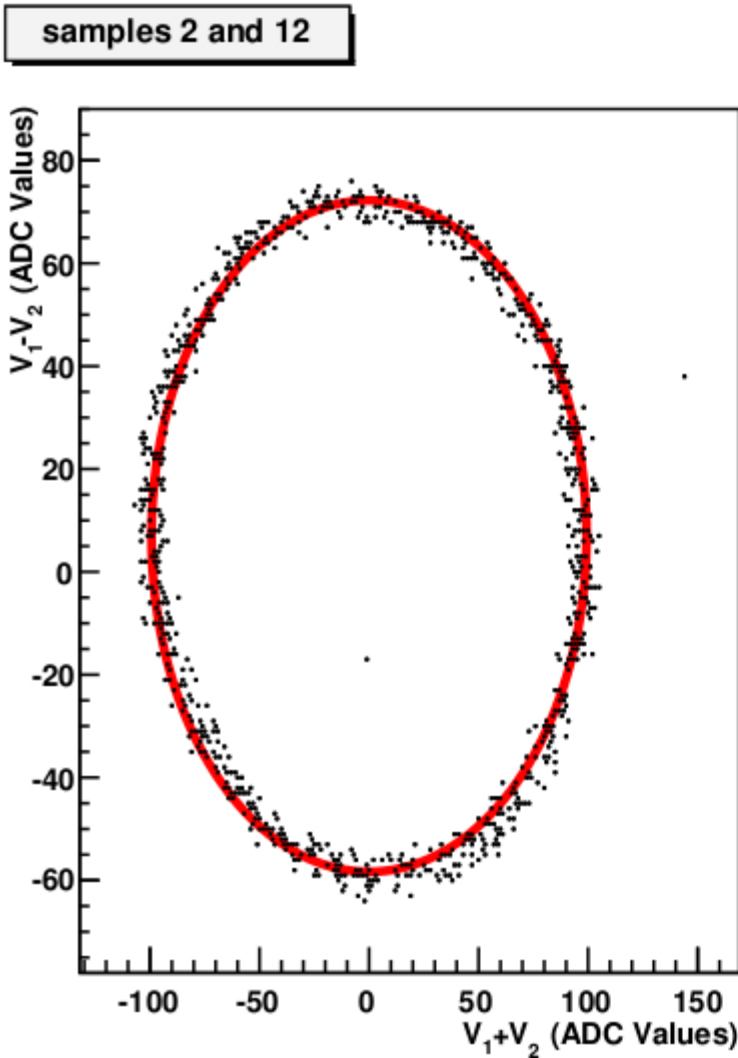
➔ Fundamental cause is still unknown, but more data under different conditions (varying input frequency, different PSEC3 channels) may help resolve it.

Timing Calibration w/ Scope data

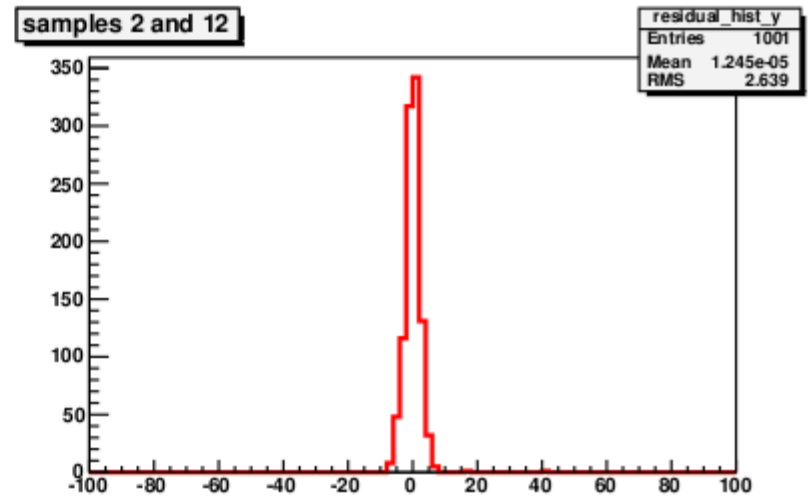
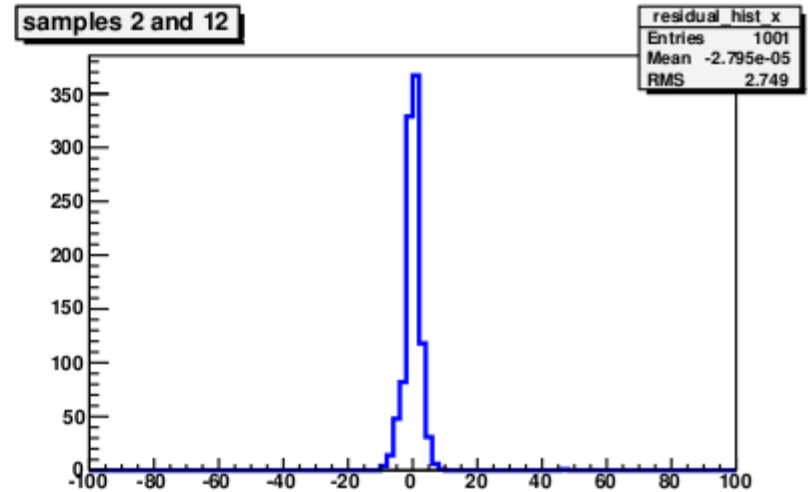
- Last set of PSEC3 data:
 - 5 GSa/s
 - CH3 (256 sample cells)
 - 1200 events (1000 usable) of:
 - 100 MHz
- Took roughly equivalent set of Tektronix data (TDS6804B):
 - 5 GSa/s
 - 500 sample cells
 - 2000 events of:
 - 100 MHz input (from an Agilent E4432B)
 - Some other sampling rates, frequencies taken, but no analyzed yet.

Example Fit (PSEC3)

Data and fit

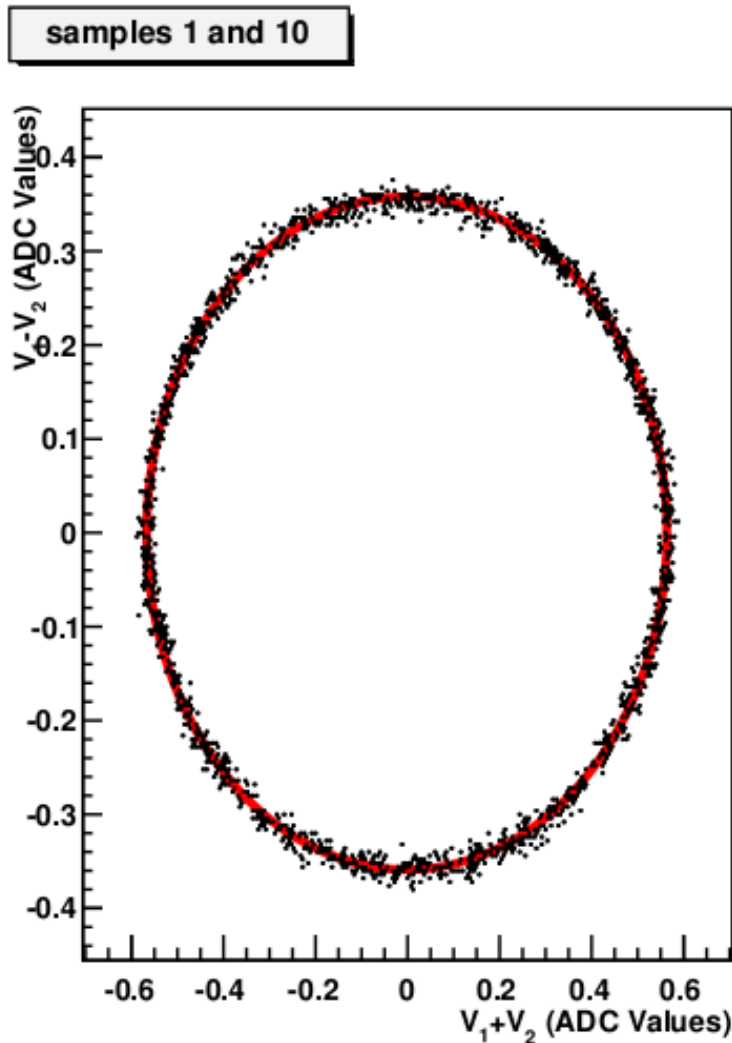


Residuals in x, y

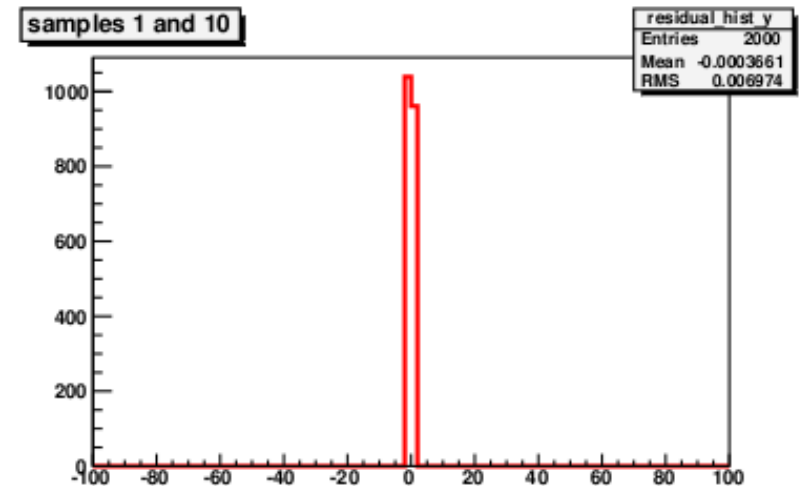
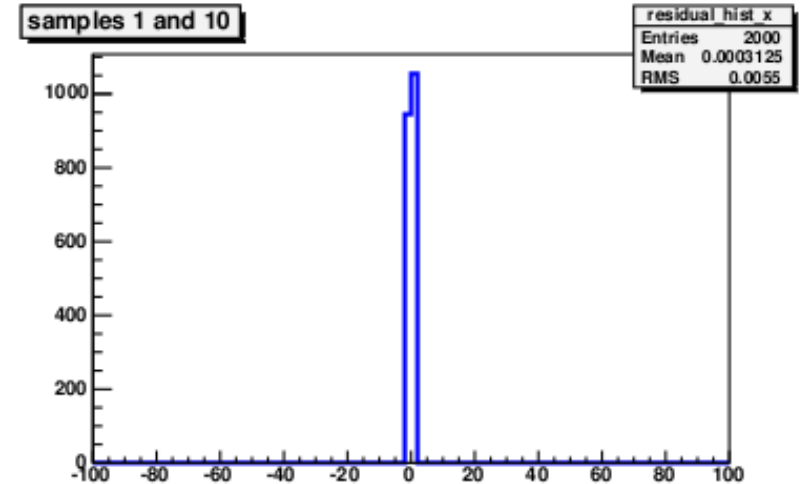


Example Fit (TDS6804B)

Data and fit



Residuals in x, y

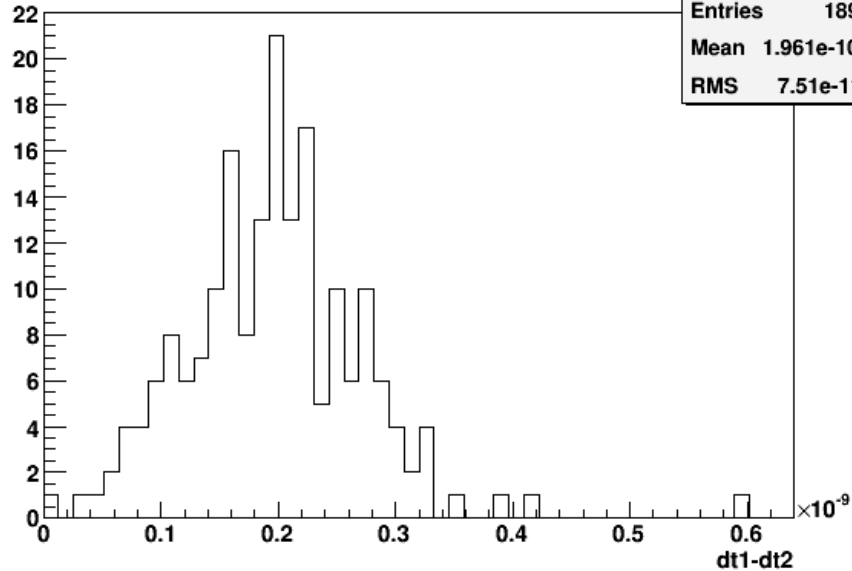


➔ Fits very well behaved. No obvious outliers, no fit failures. Very small residuals.

Derived Distributions of $\Delta t_{i,i+1}$

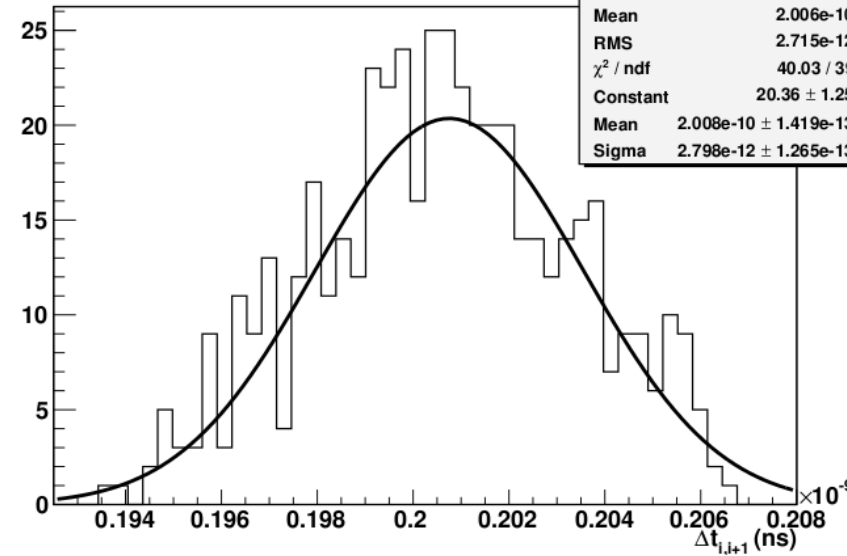
Last PSEC3 Data (1000 events)

dt1-dt2 {status1 == 0 && status2 == 0}



TDS6804B Data (1000 events)

dt1-dt2



TDS6804B Datasheet

Aperture uncertainty, typical

Short term:

≤1.5 ps rms, records having duration ≤100 ms ≤800 fs
 rms, records having duration ≤10 μs

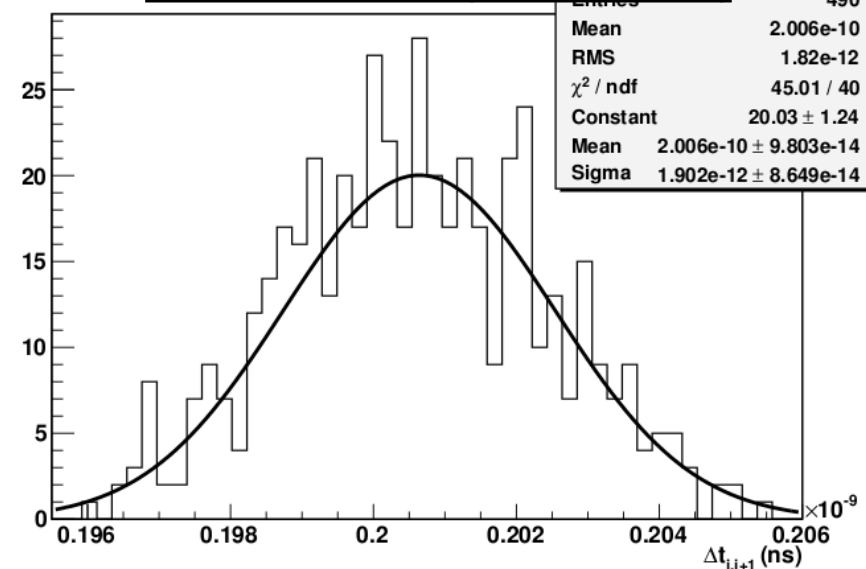
Long term:

≤15 parts per trillion rms, records having duration
 ≤1 minute

➔ Still seem statistics limited on scope data.
 Could be a valuable resource for studying
 optimal sampling rate to input frequency, error
 distributions, etc.

dt1-dt2

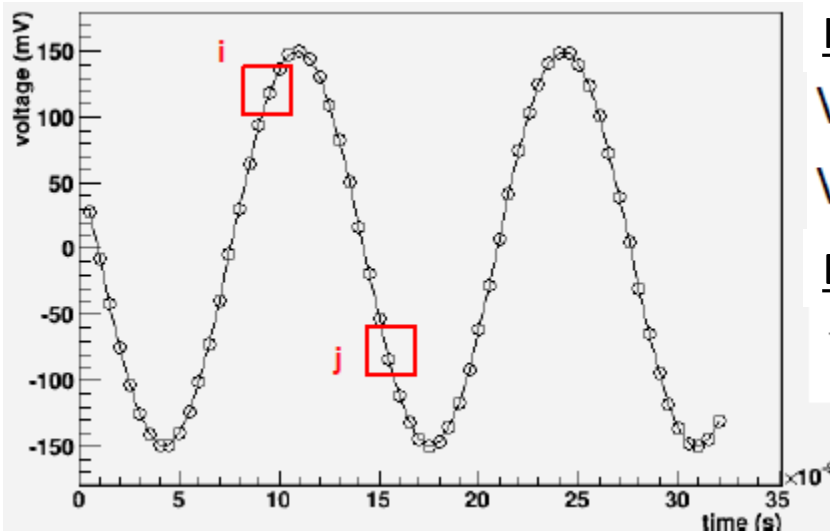
TDS6804B Data (2000 events)



BACKUP

Timing Calibration w/ Correlations

- Plot correlations between pairs of samples:
 - To determine Δt_{ij} , plot $V_i - V_j$ versus $V_i + V_j$



Input signals given by:

$$V_i = A \sin(\omega t_i + \phi)$$

$$V_j = A \sin(\omega t_j + \phi)$$

Effectively rotate by 45° :

$$- x := V_i + V_j$$

$$- y := V_i - V_j$$

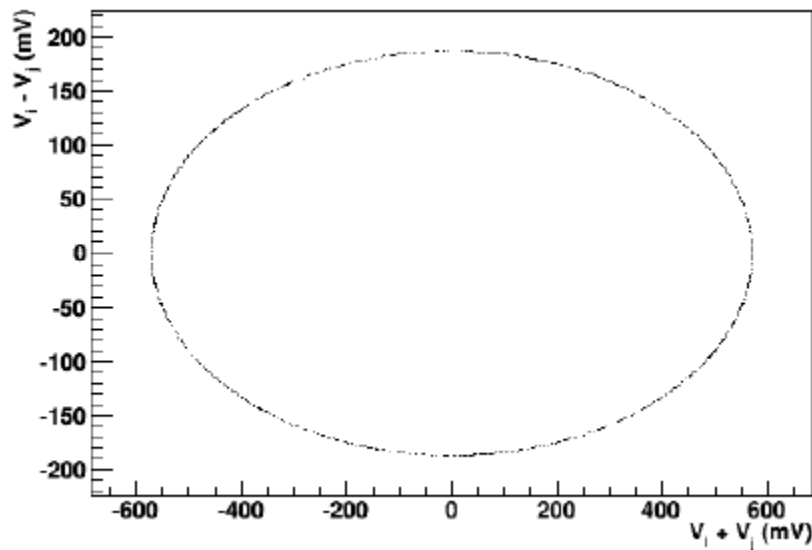
$$\rightarrow \frac{x^2}{4A^2 \cos^2(\omega \delta t / 2)} + \frac{y^2}{4A^2 \sin^2(\omega \delta t / 2)} = 1$$

i and j can be adjacent (or not), but should not be > 1 period apart.

*Method and results from Andres-Romero Wolf and myself, with data from LAB3.
Planning as TIPP submission(?)

Timing Calibration w/ Correlations

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 - To determine Δt_{ij} , plot $V_i - V_j$ versus $V_i + V_j$



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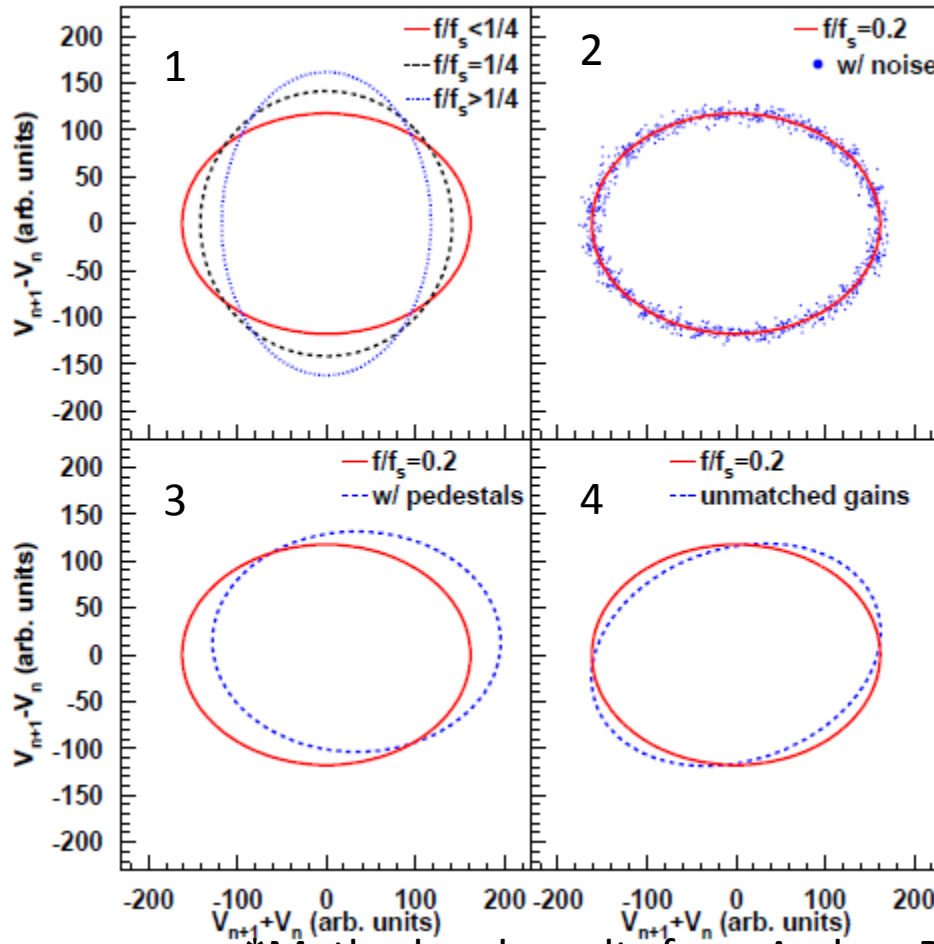
$$\rightarrow \frac{x^2}{4A^2 \cos^2(\omega \delta t / 2)} + \frac{y^2}{4A^2 \sin^2(\omega \delta t / 2)} = 1$$

i and j can be adjacent (or not), but should not be > 1 period apart.

*Method and results from Andres-Romero Wolf and myself, with data from LAB3.
Planning as TIPP submission(?)

Timing Calibration w/ Correlations

- Ellipse features:



- 1) Different Δt (for known sampling frequency) give different major/minor radii.
- 2) Noise makes ellipse “fuzzy”
- 3) Nonzero pedestals shift origin
- 4) Difference in gain between two cells causes a rotation.

- ➔ We have written an ellipse fitter to perform this method.
- ➔ Even without fitting, it provides nice qualitative check on results.

*Method and results from Andres-Romero Wolf and myself, with data from LAB3.
 Planning as TIPP submission(?)